


Search Notes 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/695,190		TSUKUDA ET AL.	
	Examiner		Art Unit	
	LaTanya Bibbins		2633	

SEARCHED			
Class	Subclass	Date	Examiner
369	44.37	7/13/2006	LB
369	44.38	7/17/2006	LB
250	559.38	7/18/2006	LB
356	4.08	7/18/2006	LB
356	624	7/18/2006	LB
369	44.36	7/18/2006	LB
369	53.19	7/18/2006	LB
369	44.11	7/18/2006	LB
356	615	7/24/2006	LB
356	622-624	7/24/2006	LB
250	559.29	7/24/2006	LB
250	559.31	7/24/2006	LB

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Databases Searched: USPAT, PSPG Pub, USOCR, EPO, JPO, DERWENT, IBM_TDB (see search history attached)	7/12/2006	LB
NPL searches including Google, IEEE Xplore, Inspec, and Optics Information Database (search terms are the same as EAST)	7/12/2006	LB
Inventor Name Search (PALM and EAST)	7/12/2006	LB